Confocal Application Notes

Vol. 4 June 2006



Data Transfer Mode Tool in LAS AF (From version 1.5.0 Build 767)

Prepared by Myriam Gastard, Ph.D. Exton Support Group, Leica Microsystems, Inc.

If you ever have samples too dim, or too sensitive to photobleaching or phototoxicity to be scanned in the best conditions, then the **Enhanced Data Mode** will become very handy in your data collection.

By default, the Direct Mode is always on (see fig. 1). In order for you to scan in Enhanced Transfer Mode, it will need to be activated **<u>before</u>** to scan.

You can follow this pathway:

⇒Configuration → Settings → Data Transfer Mode

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Data Transfer Mode pathway		Acquire aration Objective Beam F	Process Process Process Process Process Process Process		Usantify Hardware Settings Settings Settings Unaming Step Size: 10 % Line Average during Live Acquisition Line Average during Live Acquisition Line Average Data Transfer Mode Data Transfer Mode Enhanced Resolution Bit Depth: 8 bt 🔹 Online Maximum Projection during Acquisition
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Leica Microsystems Inc. 410 Eagleview Blvd, Ste. 107 Exton, PA 19341 Telephone (610)-321-0460 Toll Free 866-830-0735 Fax (610)-321-0425 www.confocal-microscopy.com

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• In **Direct data transfer mode**, (Default mode) the displayed values are directly proportional to signal from the PMT. This is the mode that you want to use for reflected light and normal fluorescence.

• In Enhanced data transfer mode, the detectors (PMTs) are electronically enhanced to detect very dim fluorescence. These values are real data with an enhanced signal. This is not a post-processing enhancement of the signal, but more of a real optimization of the PMT. This mode is optimal to display very low signals (or very sensitive sample) over the full range of gray values.



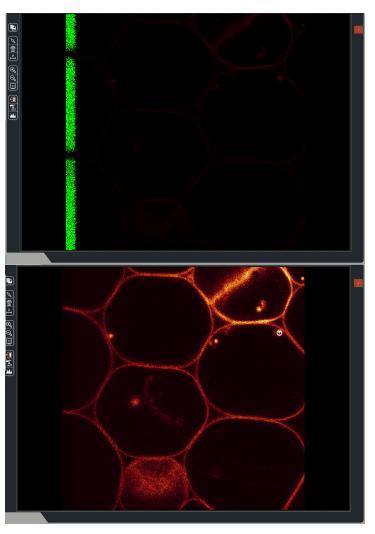
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O Direct	
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Data Transfer Mode	
Direct	
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Example:

This image (QLUT view) was taken using our Convallaria slide in direct mode. The 488 nm laser line was used at 20%, gain was at 500 V and offset at -0.1%

The same sample was then scanned using the enhanced mode. Laser power, gain and offset were the same as above.



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